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edvetry Adv itms	i entry Committee	st
udjegts Ed	ge Soon Experiments	
963; the fol ion,	fulfillpent of your request during the meeting of 3 Lonsuber Llowing naterial is presented for the committee's considers.	
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ectings deer peration enc n the scene, he applicati	itial presentations during the second and third committee wited the present status and technical approach to post- ulysis of photographic images by means of scanning edges. These presentations described the relative newness of ton, some preliminary results both in the laboratory and iterial, and some of the difficulties and potential dangers.	
equirement:		
epresentation taking the cogical step pasure of quasure of quasure from a consideration from the consideration of	e chairman requested that Perkin-Elmon and Eastman Kodak was prepare a letter for presentation at the next meeting experiments and investigation that would constitute a next in the application of "Edge Scan" as a possible objective sality. It was understood that HE	ST ST
ovolomeni C	할 때 사람들이 사이를 모든 그를 수 있는 것을 모른다는 것을 모든다고 살아왔다.	
ceming and	ed on our prosent knowledge and understanding of edge ysis, it appears ressonable to establish the following I long term goals for the spatial frequencies of interest.	
4.0	Establish the reliability of recent experiments,	
2.	Determine the most promising data handling technique.	
3.	Measure the variability of existing microdensitometer instruments.	
4.0	Accumplate dats from future missions.	
5.	Determine the practicality of any feasible methods developed.	
6.	Determine if extending the analysis to past material is warranted.	
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Experiments and Inventigations:

The list below is certainly not all-inclusive and may in some cases be redundant. This preliminary list is submitted in an attempt to obtain the essential information to decomplish the goals above.

- 1. To establish reliability of recent experiments:
 - a.) Perform similation with sufficient replication to establish variability of the data within and between the three matheds of ocquiring resolution, i.e. visual resolution, MTF from size wave targets, and MTF from edge scanning. The resulting MTF surves can be combined with a film modulation threshold curve to predict resolution.
 - b.) Measure the Modulation Transfer Function (MIF) of the present microdensitemeter slit.
- 2. To determine most promising data handling technique:
 - a.) Perform tests with wider and longer slits (for less noise), being careful to knew the measured NTF for each slit size used.
 - b.) Perform tests with existing (or modified) "electronic" scenners such as MIT Line Scan and investigate direct display output devices.
 - c.) Examine promising data smoothing methods (manual, chalce, digital).
- 3. To measure variability of oxisting instruments:
 - a.) Run sufficient scens on each instrument to determine its own consistency on a standard target.
 - b.) With a single set of test objects run edge scans on several different instruments using a common technique and measure variability between instruments. Micro-densitoreter at SK, FE, Italy, SFPL and MPIC would be suggested.
- A. To accumulate data on Tabure wissions:
 - a.) On the same incurrence(e), select and measure seges from ell future C/M/J mission material. It is recommended that this to dame at a government laboratory responsible for analysis and/or use of output material.



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- 5. To determine preciseality:
 - a.) Evaluate measurement and data handling practices from the standpoint of mustant required per eage. The best technique may be of little value if it is too condersome for "production" use.
- 6. To someider extending enelysis to past materials

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a.) On the basis of results in 1 through 4 above it may be advisable to re-evaluate come past C/M/J mission material in order that it may be related on a source scale with the material from 4.

Statuse

Certain of the experiments proposed above were obvious enough to be started immediately. Both is and its are already in progress on our own microdensitemeters. Test 2s is planned for the near future. 2b would depend on the availability of other equipment such as that at MIT. Data amouthing in 2s is being pursued in the manual and digital form at EE. This is the type of investigation that could be done in parallel at several laboratories.

Test Ja has been initiated on two of our instruments. In has not yet been started, but FE and SPPL have already volunteered the use of their microdensitometers for this test. We would be happy to fornish the targets that were used in the simulation experiment.

Test is (mission edges) has not been initiated in any formal way. Ex plans to continue measuring a modest number of edges under an existing contract to aid in developing the technique. If any large casic measurement program is to be performed it should be done by MPIC or SPPL, but no conclusions should be drawn from the measurements, for do not consider it a formal evaluation tool, until the technique and its shortcomings are well understood and the decision has been made that it can serve a useful purpose.

Test 5 has not been started. After feasible testinines are developed, they should be tested to determine the elapsed time required by each.

Undertaking test 6 on past material should be considered only in the light of significant positive results from tests 1 through 5.

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SUMMARY:

These investigations are suggested as the next step in evaluating the edge scan technique. They are obviously not the sum total of all tests that could or should be run, but they should provide information that would either (a.) help substantiate the consistency of the technique as a usable tool, or (b.) uncover questionable areas in need of refinement and/or further testing. We would be presumptious in predicting the outcome at this time, but the development would be an unusual one if all our questions were answered at the end of the second series of tests.

	(SIGNED)	STA
WRE/PMC Orig. + 1:		STA

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